

P-Channel 20 V (D-S) 175 °C MOSFET

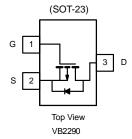
PRODUCT SUMMARY				
V _{DS} (V)	- 20			
$R_{DS(on)}$ (Ω) at $V_{GS} = -4.5 \text{ V}$	0.075			
$R_{DS(on)}$ (Ω) at $V_{GS} = -2.5 \text{ V}$	0.080			
I _D (A)	- 3.5			
Configuration	Single			

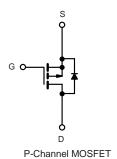
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



FREE





ABSOLUTE MAXIMUM RATINGS (To	$_{\rm C} = 25 ^{\circ}{\rm C}$, unles	ss otherwise noted	l)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V_{DS}	- 20	V	
Gate-Source Voltage		V_{GS}	± 8	V	
Continuous Drain Current	T _C = 25 °C	1	- 3.5		
	T _C = 125 °C	- I _D	- 2.5		
Continuous Source Current (Diode Conduction) ^a		I _S	- 5	Α	
Pulsed Drain Current ^b		I _{DM}	-15		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	- 6		
Single Pulse Avalanche Energy	L = 0.1 IIIII	E _{AS}	4	mJ	
Maximum Power Dissipation ^b	T _C = 25 °C	D	3	W	
	T _C = 125 °C	P _D	1] vv	
Operating Junction and Storage Temperature Ran	ge	T _J , T _{stg}	- 55 to + 175	°C	

THERMAL RESISTANCE RATINGS				
PARAMETER		SYMBOL	LIMIT	UNIT
Junction-to-Ambient	PCB Mount ^c	R_{thJA}	166	°C/W
Junction-to-Foot (Drain)		R _{thJF}	50	C/VV

Notes

- a. Package limited.
- b. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- c. When mounted on 1" square PCB (FR-4 material).
- d. Parametric verification ongoing.

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SPECIFICATIONS ($T_C = 25$ °C,	unless otherv	vise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0, I _D = - 250 μA	- 20	-	-	V	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = -250 \mu A$ -		-	- 1.5	\ \	
Gate-Source Leakage	I _{GSS}	V _{DS} =	= 0 V, V _{GS} = ± 8 V	-	-	± 100	nA	
		V _{GS} = 0 V	V _{DS} = - 20 V	-	-	- 1		
Drain-Source Breakdown Voltage Gate-Source Threshold Voltage Gate-Source Leakage Zero Gate Voltage Drain Current Dn-State Drain Currenta Drain-Source On-State Resistancea Forward Transconductancea Dynamicb Input Capacitance Dutput Capacitance Reverse Transfer Capacitance Total Gate Chargec Gate-Source Chargec Gate-Drain Chargec Gate-Drain Chargec Gate Resistance	I _{DSS}	V _{GS} = 0 V	V _{DS} = - 20 V, T _J = 125 °C	-	-	- 50	μΑ	
		V _{GS} = 0 V	V _{DS} = - 20 V, T _J = 175 °C	-	-	- 150	1	
On-State Drain Current ^a	I _{D(on)}	V _{GS} = - 4.5 V	$V_{DS} \ge 5 V$	- 8	-	-	Α	
Duein Course On Chata Besintance		V _{GS} = - 4.5 V	I _D = - 2.8 A	-	0.075	0.085	V	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 2.5 V	I _D = - 2 A	-	0.080	0.100		
Forward Transconductance ^a	9fs	V _{DS} =	- 1.6 V, I _D = - 2.8 A	-	7	-	S	
Dynamic ^b							•	
Input Capacitance	C _{iss}			-	340	425		
Output Capacitance	C _{oss}	$V_{GS} = 0 V$	V _{DS} = - 10 V, f = 1 MHz	-	80	100	pF	
Reverse Transfer Capacitance	C _{rss}	1		-	55	70		
Total Gate Charge ^c	Qg			-	5	8		
Gate-Source Charge ^c	Q _{gs}	V _{GS} = - 4.5 V	$V_{DS} = -10 \text{ V}, I_{D} = -2.8 \text{ A}$	-	0.7	-	nC	
Gate-Drain Charge ^c	Q _{gd}]		-	1.3	-		
Gate Resistance	R_g		f = 1 MHz	5.5	10	14.5	Ω	
Turn-On Delay Time ^c	t _{d(on)}			-	15	22		
Rise Time ^c	t _r	V _{DD} =	- 10 V, $R_1 = 10 \Omega$	-	14	21		
Turn-Off Delay Time ^c	t _{d(off)}	$V_{DD} = -10 \text{ V}, R_L = 10 \Omega$ $I_D \cong -1 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		30	45	ns		
Fall Time ^c	t _f			-	9	15	1	
Source-Drain Diode Ratings and Char-	acteristics ^b							
Pulsed Current ^a	I _{SM}			-	-	- 3	Α	
Forward Voltage	V _{SD}	l _F =	- 1.6 A, V _{GS} = 0	-	- 0.8	- 1.2	V	

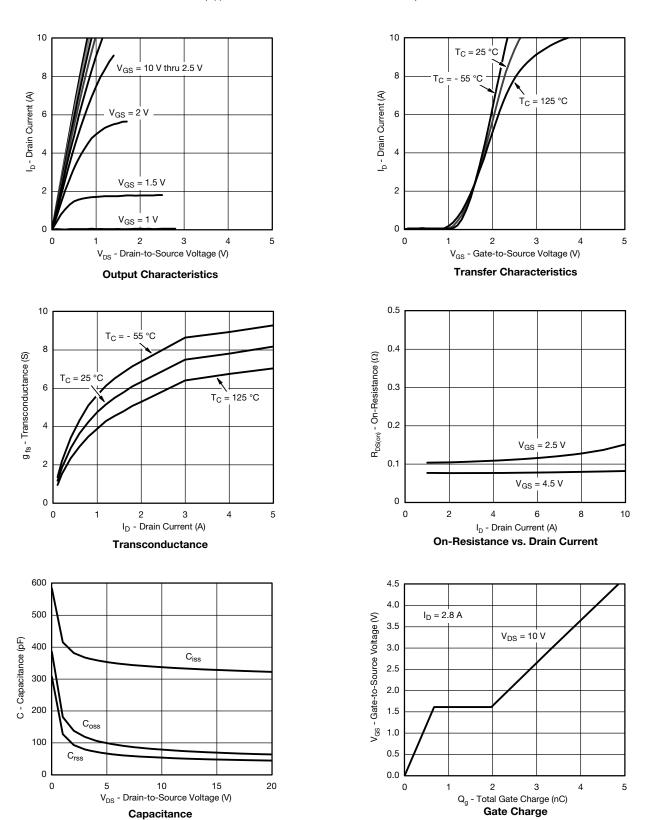
Notes

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

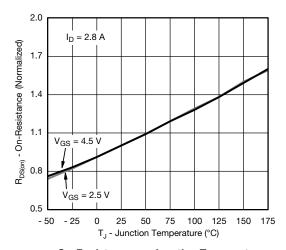


TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)

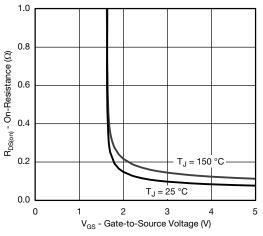




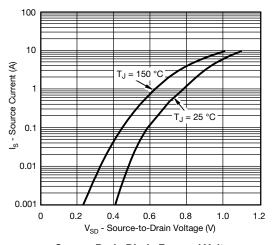
TYPICAL CHARACTERISTICS ($T_A = 25$ °C, unless otherwise noted)



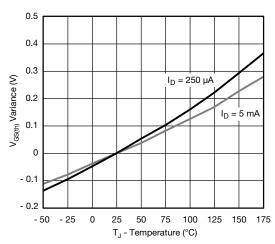
On-Resistance vs. Junction Temperature



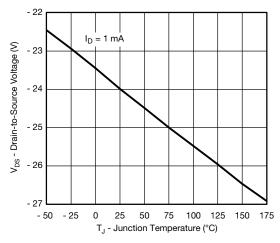
On-Resistance vs. Gate-to-Source Voltage



Source-Drain Diode Forward Voltage



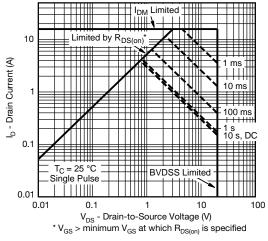
Threshold Voltage



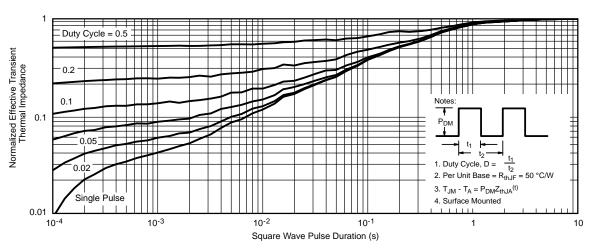
Drain Source Breakdown vs. Junction Temperature



THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



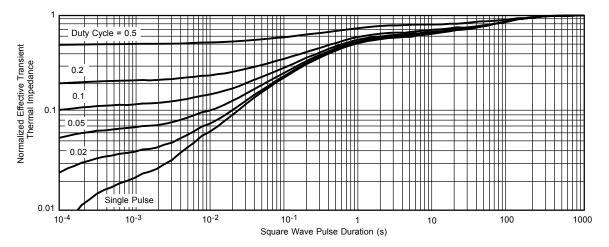
Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Foot



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

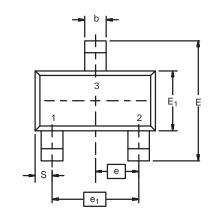
Note

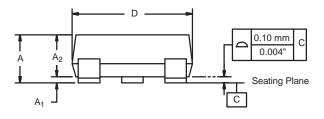
- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
 - Normalized Transient Thermal Impedance Junction-to-Foot (25 °C)

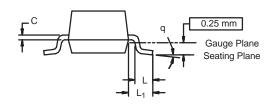
are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



SOT-23 (TO-236): 3-LEAD





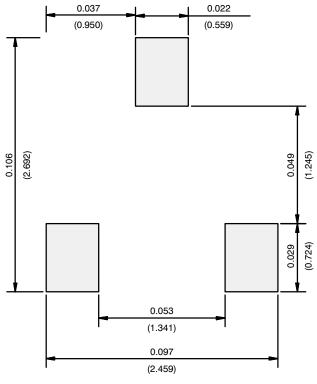


Dim -	MILLIM	IETERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A ₁	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
С	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e ₁	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L ₁	0.64 Ref		0.025 Ref		
S	0.50 Ref		0.020 Ref		
q	3°	8°	3°	8°	

DWG: 5479



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)



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